

FEATURES

 Controlled Baseline One Assembly/Test Site, One Fabrication Site 	PW PACKAGE (TOP VIEW)					
 Enhanced Diminishing Manufacturing Sources (DMS) Support 	$(5 \text{ V}) \text{ V}_{\text{CCA}} \begin{bmatrix} 1 & 24 \end{bmatrix} \text{ V}_{\text{CCB}} (3.3 \text{ V})$ DIR $\begin{bmatrix} 2 & 23 \end{bmatrix} \text{ V}_{\text{CCB}} (3.3 \text{ V})$					
 Enhanced Product-Change Notification Qualification Pedigree ⁽¹⁾ 	A1 [3 22] OE A2 [4 21] B1 A3 [5 20] B2					
Bidirectional Voltage Translator	A4 [6 19] B3					
• 5.5 V on A Port and 2.7 V to 3.6 V on B Port	A5 🛛 7 🛛 18 🗋 B4					
 Latch-Up Performance Exceeds 250 mA Per JESD 17 	A6 [8 17] B5 A7 [9 16] B6					
 ESD Protection Exceeds JESD 22 2000-V Human-Body Model (A114-A) 200-V Machine Model (A115-A) 	A8 [10 15] B7 GND [11 14] B8 GND [12 13] GND					

life. Such qualification testing should not be viewed as justifying use of this component beyond specified

electromigration, bond intermetallic life, and mold compound

temperature cvcle, autoclave or unbiased HAST.

 - 1000-V Charged-Device Model (C101)
 (1) Component qualification in accordance with JEDEC and industry standards to ensure reliable operation over an extended temperature range. This includes, but is not limited to, Highly Accelerated Stress Test (HAST) or biased 85/85,

performance and environmental limits.

DESCRIPTION/ORDERING INFORMATION

This 8-bit (octal) noninverting bus transceiver contains two separate supply rails; B port has V_{CCB} , which is set at 3.3 V, and A port has V_{CCA} , which is set at 5 V. This allows for translation from a 3.3-V to a 5-V environment, and vice versa.

The SN74LVC4245A is designed for asynchronous communication between data buses. The device transmits data from the A bus to the B bus or from the B bus to the A bus, depending on the logic level at the direction-control (DIR) input. The output-enable (OE) input can be used to disable the device so the buses are effectively isolated.

The SN74LVC4245A pinout allows the designer to switch to a normal all-3.3-V or all-5-V 20-pin '245 device without board re-layout. The designer uses the data paths for pins 2–11 and 14–23 of the SN74LVC4245A to align with the conventional '245 pinout.

T _A	PACK	AGE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	TSSOP – PW	Reel of 2000	SN74LVC4245AIPWREP	C4245AEP

ORDERING INFORMATION

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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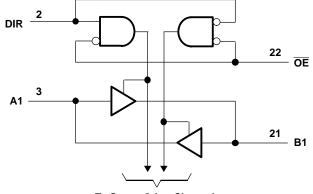
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FUNCTION TABLE

INP	UTS	OPERATION
OE	DIR	OPERATION
L	L	B data to A bus
L	Н	A data to B bus
Н	Х	Isolation

LOGIC DIAGRAM (POSITIVE LOGIC)



To Seven Other Channels

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Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range for V_{CCA} = 4.5 V to 5.5 V (unless otherwise noted)

			MIN	MAX	UNIT
V _{CCA}	Supply voltage range		-0.5	6.5	V
		A port ⁽²⁾	-0.5	V _{CCA} + 0.5	N/
VI	Input voltage range	Control inputs	-0.5	6	V
Vo	Output voltage range	A port ⁽²⁾	-0.5	V _{CCA} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
	Continuous current through V _{CCA} or GND			±100	mA
θ_{JA}	Package thermal impedance ⁽³⁾		88	°C/W	
T _{stg}	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) This value is limited to 6 V maximum.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range for $V_{CCB} = 2.7$ V to 3.6 V (unless otherwise noted)

			MIN	MAX	UNIT
V _{CCB}	Supply voltage range		-0.5	4.6	V
VI	Input voltage range	B port ⁽²⁾	-0.5	V _{CCB} + 0.5	V
Vo	Output voltage range	B port ⁽²⁾	-0.5	$V_{CCB} + 0.5$	V
I _{IK}	Input clamp current	V _I < 0		-50	mA
I _{OK}	Output clamp current	V _O < 0		-50	mA
I _O	Continuous output current			±50	mA
	Continuous current through V _{CCB} or GND			±100	mA
θ_{JA}	Package thermal impedance ⁽³⁾		88	°C/W	
T _{stg}	Storage temperature range		-65	150	°C

 Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) This value is limited to 4.6 V maximum.

(3) The package thermal impedance is calculated in accordance with JESD 51-7.



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Recommended Operating Conditions⁽¹⁾

for V_{CCA} = 4.5 V to 5.5 V

		MIN	MAX	UNIT
V_{CCA}	Supply voltage	4.5	5.5	V
V_{IH}	High-level input voltage	2		V
VIL	Low-level input voltage		0.8	V
VI	Input voltage	0	V_{CCA}	V
Vo	Output voltage	0	V_{CCA}	V
I _{OH}	High-level output current		-24	mA
I _{OL}	Low-level output current		24	mA
T _A	Operating free-air temperature	-40	85	°C

(1) All unused inputs of the device must be held at the associated V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

Recommended Operating Conditions⁽¹⁾

for $V_{CCB} = 2.7$ V to 3.6 V

			MIN	MAX	UNIT
V _{CCB}	Supply voltage		2.7	3.6	V
VIH	High-level input voltage	$V_{CCB} = 2.7 \text{ V to } 3.6 \text{ V}$	2		V
VIL	Low-level input voltage	$V_{CCB} = 2.7 V \text{ to } 3.6 V$		0.8	V
VI	Input voltage	0	V_{CCB}	V	
Vo	Output voltage				
	High lovel output ourrent	$V_{CCB} = 2.7 V$		-12	mA
юн	High-level output current	$V_{CCB} = 3 V$		-24	ША
		V _{CCB} = 2.7 V		12	~ ^
I _{OL}	Low-level output current $V_{CCB} = 3 V$			24	mA
T _A	Operating free-air temperature		-40	85	°C

All unused inputs of the device must be held at the associated V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

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Electrical Characteristics⁽¹⁾

over recommended operating free-air temperature range for V_{CCA} = 4.5 V to 5.5 V (unless otherwise noted)

PA	ARAMETER	TEST CONDITIONS	V _{CCA}	MIN TYP ⁽²⁾	MAX	UNIT
		4004	4.5 V	4.3		
		I _{OH} = -100 μA	5.5 V	5.3		V
V _{OH}		1	4.5 V	3.7		V
		$I_{OH} = -24 \text{ mA}$	5.5 V	4.7		
V _{OL}		4004	4.5 V		0.2	
		I _{OL} = 100 μA	5.5 V		0.2	V
		1 04 mA	4.5 V		0.55	v
		$I_{OL} = 24 \text{ mA}$	5.5 V		0.55	
I _I	Control inputs	V _I = V _{CCA} or GND	5.5 V		±1	μA
$I_{OZ}^{(3)}$	A port	$V_{O} = V_{CCA}$ or GND	5.5 V		±5	μA
I _{CCA}		$V_1 = V_{CCA} \text{ or } GND, \qquad I_O = 0$	5.5 V		80	μA
$\Delta I_{CCA}^{(4)}$		One input at 3.4 V, Other inputs at V_{CCA} or GND	5.5 V		1.5	mA
Ci	Control inputs	V _I = V _{CCA} or GND	Open	5		pF
Cio	A port	$V_{O} = V_{CCA}$ or GND	5 V	11		pF

(1)

(2)

(3)

 $V_{CCB} = 2.7$ V to 3.6 V All typical values are measured at $V_{CC} = 5$ V, $T_A = 25^{\circ}$ C. For I/O ports, the parameter I_{OZ} includes the input leakage current. This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or the associated (4) V_{CC}.

Electrical Characteristics⁽¹⁾

over recommended operating free-air temperature range for V_{CCB} = 2.7 V to 3.6 V (unless otherwise noted)

PAR	AMETER	TEST CONDITIONS	V _{CCB}	ΜΙΝ ΤΥ	'P ⁽²⁾ MAX	UNIT
		I _{OH} = -100 μA	2.7 V to 3.6 V	V _{CC} – 0.2		
V		1 10 mA	2.7 V	2.2		V
V _{OH}		$I_{OH} = -12 \text{ mA}$	3 V	2.4		v
		$I_{OH} = -24 \text{ mA}$	3 V	2		
		I _{OL} = 100 μA	2.7 V to 3.6 V		0.2	
V _{OL}		I _{OL} = 12 mA	2.7 V		0.4	V
		I _{OL} = 24 mA	3 V		0.55	
$I_{OZ}^{(3)}$	B port	$V_{O} = V_{CCB}$ or GND	3.6 V		±5	μA
I _{CCB}		$V_{I} = V_{CCB} \text{ or } GND, \qquad I_{O} = 0$	3.6 V		50	μA
$\Delta I_{CCB}^{(4)}$)	One input at $V_{CCB} - 0.6 V$, Other inputs at V_{CCB} or GNI	D 2.7 V to 3.6 V		0.5	mA
C _{io}	B port	$V_{O} = V_{CCB}$ or GND	3.3 V		11	pF

 V_{CCA} = 5 V ± 0.5 V
 All typical values are measured at V_{CC} = 3.3 V, T_A = 25°C.
 For I/O ports, the parameter I_{OZ} includes the input leakage current.
 This is the increase in supply current for each input that is at one of the specified TTL voltage levels, rather than 0 V or the associated to the specified TTL voltage levels. V_{CC}.

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Switching Characteristics

over recommended operating free-air temperature range, C_L = 50 pF (unless otherwise noted) (see Figure 1 and Figure 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CCA} = 5 V \pm V _{CCB} = 2.7 V t	V_{CCA} = 5 V \pm 0.5 V, V_{CCB} = 2.7 V to 3.6 V		
	(INFOT)	(001F01)	MIN	MAX		
t _{PHL}	А	В	1	6.3	20	
t _{PLH}	A	D	1	6.7	ns	
t _{PHL}	В	А	1	6.1	20	
t _{PLH}	D	A	1	5	ns	
t _{PZL}	OE	А	1	9	-	
t _{PZH}	0E	A	1	8.1	ns	
t _{PZL}	ŌĒ	В	1	8.8	20	
t _{PZH}	0E	D	1	9.8	ns	
t _{PLZ}	ŌĒ	А	1	7	20	
t _{PHZ}	0E	A	1	5.8	ns	
t _{PLZ}	ŌĒ	В	1	7.7		
t _{PHZ}	0E	В	1	7.8	ns	

Operating Characteristics

 V_{CCA} = 4.5 V to 5.5 V, V_{CCB} = 2.7 V to 3.6 V, T_A = 25°C

	PARAMETER	TEST C	ONDITIONS	TYP	UNIT	
C _{pd}	Dower dissipation consistence per transceiver	Outputs enabled	C 0	£ 10 MU	39.5	~ F
	Power dissipation capacitance per transceiver	Outputs disabled	$C_{L} = 0,$	f = 10 MHz	5	р⊦

Power-up Considerations⁽¹⁾

TI level-translation devices offer an opportunity for successful mixed-voltage signal design. A proper power-up sequence always should be followed to avoid excessive supply current, bus contention, oscillations, or other anomalies caused by improperly biased device pins. Take these precautions to guard against such power-up problems.

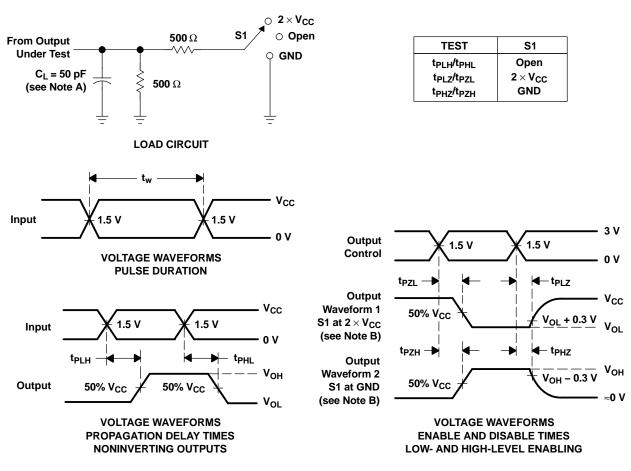
- 1. Connect ground before any supply voltage is applied.
- 2. Power up the control side of the device (V_{CCA} for all four of these devices).
- 3. Tie \overline{OE} to V_{CCA} with a pullup resistor so that it ramps with V_{CCA}.
- 4. Depending on the direction of the data path, DIR can be high or low. If DIR high is needed (A data to B bus), ramp it with V_{CCA}. Otherwise, keep DIR low.
- (1) Refer to the TI application report, Texas Instruments Voltage-Level-Translation Devices, literature number SCEA021.

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SN74LVC4245A-EP OCTAL BUS TRANSCEIVER AND 3.3-V TO 5-V SHIFTER WITH 3-STATE OUTPUTS

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PARAMETER MEASUREMENT INFORMATION A PORT

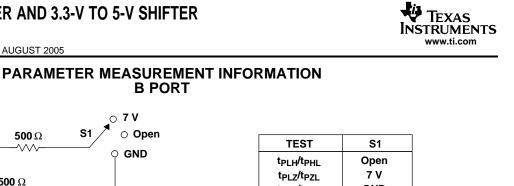


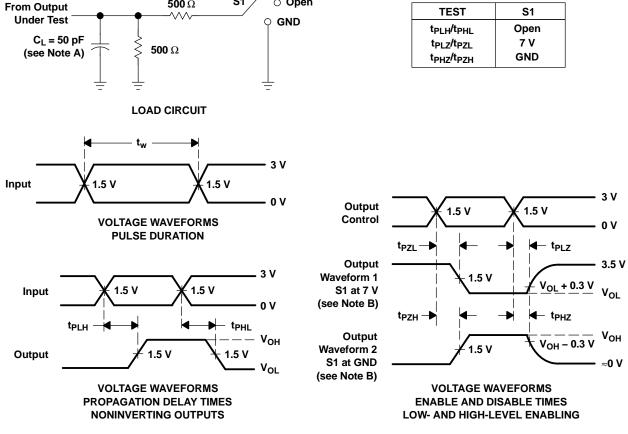
- NOTES: A. C_L includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_Q = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

500 Ω

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B PORT

07V

O Open

S1

- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time, with one transition per measurement.
 - E. All parameters and waveforms are not applicable to all devices.

Figure 2. Load Circuit and Voltage Waveforms



10-Dec-2020

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LVC4245AIPWREP	ACTIVE	TSSOP	PW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	C4245AEP	Samples
V62/04664-01XE	ACTIVE	TSSOP	PW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	C4245AEP	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

10-Dec-2020

OTHER QUALIFIED VERSIONS OF SN74LVC4245A-EP :

• Catalog: SN74LVC4245A

NOTE: Qualified Version Definitions:

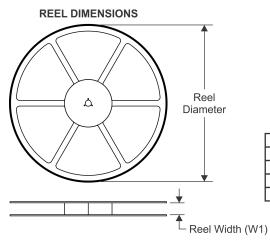
Catalog - TI's standard catalog product

PACKAGE MATERIALS INFORMATION

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TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal													
	Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
	SN74LVC4245AIPWREP	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1

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PACKAGE MATERIALS INFORMATION

17-Dec-2020



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
SN74LVC4245AIPWREP	TSSOP	PW	24	2000	853.0	449.0	35.0	

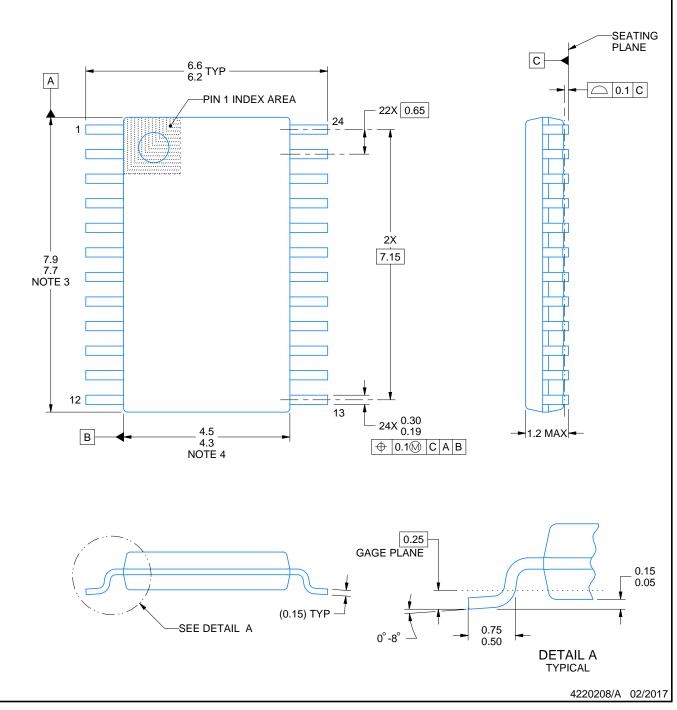
PW0024A



PACKAGE OUTLINE

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



PW0024A

EXAMPLE BOARD LAYOUT

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

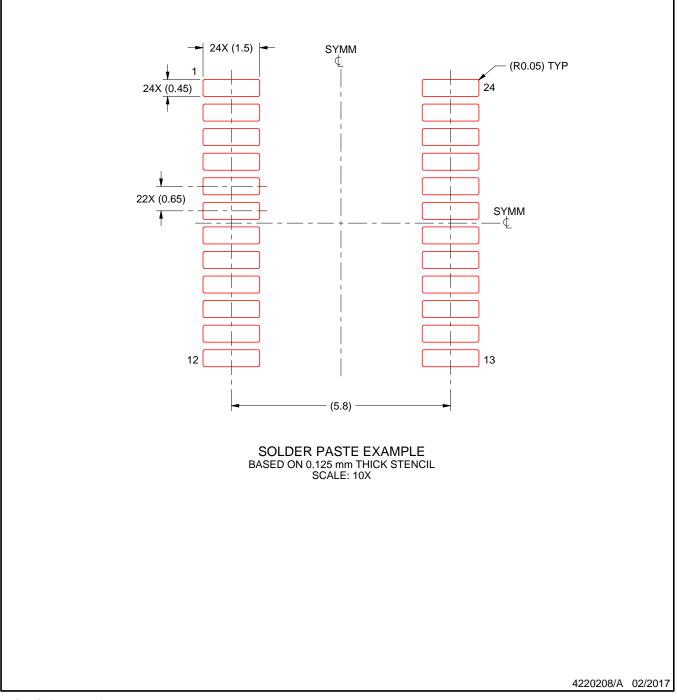


PW0024A

EXAMPLE STENCIL DESIGN

TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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